MOSFET - Power, Single, N-Channel, SO-8 FL 30 V, 38 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Optimized for 5 V, 12 V Gate Drives
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_{.1} = 25°C unless otherwise stated)

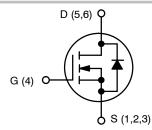
Parameter			Symbol	Value	Unit
Drain-to-Source Volt	Drain-to-Source Voltage			30	V
Gate-to-Source Volta	age		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	13.6	Α
Current R _{0JA} (Note 1)		T _A = 100°C		8.6	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P_{D}	2.70	W
Continuous Drain		T _A = 25°C	I _D	20.4	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 100°C		12.9	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	6.04	W
Continuous Drain Current R _{0JA}	State	T _A = 25°C	I _D	7.9	Α
(Note 2)		T _A = 100°C		5.0	
Power Dissipation R ₀ JA (Note 2)		T _A = 25°C	P _D	0.92	W
Continuous Drain		T _C = 25°C	I _D	38	Α
Current R _{θJC} (Note 1)		T _C =100°C		24	
Power Dissipation R ₀ JC (Note 1)		T _C = 25°C	P _D	20.8	W
Pulsed Drain Current	T _A = 25°	°C, t _p = 10 μs	I _{DM}	160	Α
Current Limited by Pa	ackage	T _A = 25°C	I _{Dmax}	100	Α
Operating Junction ar Temperature	perating Junction and Storage mperature			-55 to +150	°C
Source Current (Body	/ Diode)		IS	21	Α
Drain to Source DV/DT			dV/d _t	6.0	V/ns



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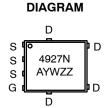
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	7.3 mΩ @ 10 V	38 A
30 V	12.0 mΩ @ 4.5 V	36 A



N-CHANNEL MOSFET



SO-8 FLAT LEAD CASE 488AA STYLE 1



MARKING

4927N = Specific Device Code = Assembly Location Α

= Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4927NT1G	SO-8 FL	1500 /
NTMFS4927NCT1G	(Pb-Free)	Tape & Reel
NTMFS4927NT3G	SO-8 FL	5000 /
NTMFS4927NCT3G	(Pb-Free)	Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 24 V, V_{GS} = 20 V, I_L = 20 A_{pk} , L = 0.1 mH, R_G = 25 Ω)	E _{AS}	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	ů

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	6.0	
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	46.3	0000
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	136.2	°C/W
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	20.7	1

- 3. Surface–mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	VGS = 0 V, $I_{D(aval)}$ = 8.4 A, T_{case} = 25°C, $t_{transient}$ = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				24		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.32	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		5.8	7.3	
			I _D = 15 A		5.7		0
		V _{GS} = 4.5 V	I _D = 30 A		9.6	12	mΩ
			I _D = 15 A		9.2		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _E	₎ = 15 A		40		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}				913		
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = 15 \text{ V}$ $V_{GS} = 0 \text{ V}, V_{DS} = 15 \text{ V}, f = 1 \text{ MHz}$			366		pF
Reverse Transfer Capacitance	C _{RSS}				108		
Capacitance Ratio	C _{RSS} / C _{ISS}				0.118	0.237	

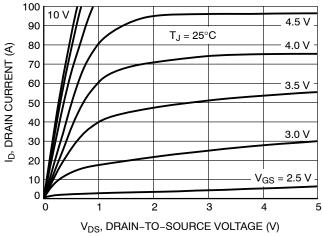
- 5. Pulse Test: pulse width \leq 300 $\mu\text{s},$ duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	Test Condition		Тур	Max	Unit
CHARGES, CAPACITANCES & GATE	RESISTANCE				•		•
Total Gate Charge	$Q_{G(TOT)}$				8.0		nC
Threshold Gate Charge	Q _{G(TH)}				1.6		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$		3.1		
Gate-to-Drain Charge	Q_{GD}				3.1		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 1	5 V; I _D = 30 A		16.0		nC
SWITCHING CHARACTERISTICS (No	ote 6)				-		
Turn-On Delay Time	t _{d(ON)}				9.2		
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			25.5		ns
Turn-Off Delay Time	t _{d(OFF)}				14.0		
Fall Time	t _f				4.4		
Turn-On Delay Time	t _{d(ON)}				6.5		
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			21.0		ns
Turn-Off Delay Time	t _{d(OFF)}				18.0		
Fall Time	t _f				3.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-		
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.87	1.1	V
		I _S = 30 A	T _J = 125°C		0.76		V
Reverse Recovery Time	t _{RR}				21.4		
Charge Time	ta	V _{GS} = 0 V, dIS/dt =	= 100 A/μs,		10.5		ns
Discharge Time	t _b	I _S = 30 /	4		10.9		
Reverse Recovery Charge	Q _{RR}	1			8.4		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				1.00		nH
Drain Inductance	L _D	T 050	0		0.005		nΗ
Gate Inductance	L _G	T _A = 25°C			1.84		nΗ
Gate Resistance	R _G				0.90	2.2	Ω
-							

^{5.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

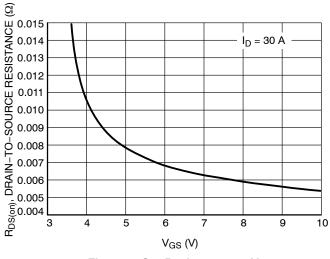
TYPICAL CHARACTERISTICS



100 $T_J = -55^{\circ}C$ 90 80 $T_{.1} = 25^{\circ}C$ ID, DRAIN CURRENT (A) 70 = 125°C 60 $V_{DS} = 10 V$ 50 40 30 20 10 0 2 3 4 5

V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics





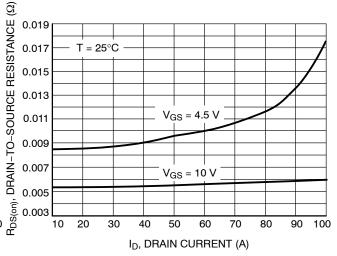
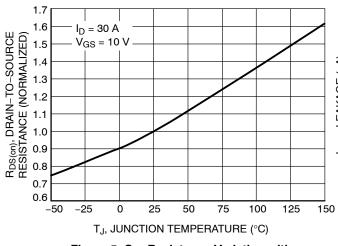


Figure 3. On-Resistance vs. V_{GS}





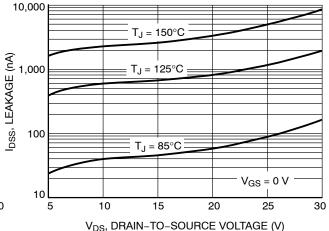


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

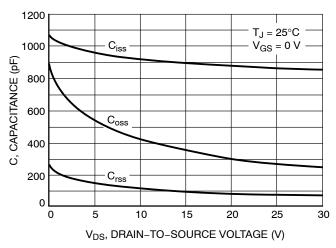


Figure 7. Capacitance Variation

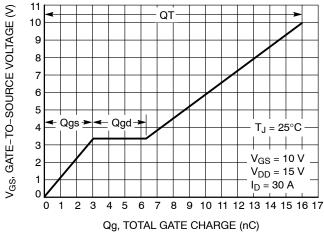
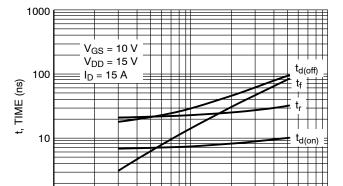


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



 R_G , GATE RESISTANCE (Ω)

1

30 $V_{GS} = 0 V$ 25 SOURCE CURRENT (A) 20 15 10 $T_J = 125^{\circ}C$ T_J = 25°C 5 0 0.7 0.8 0.3 0.4 0.5 0.6 0.9 1.0

V_{SD}, SOURCE-TO-DRAIN VOLTAGE (V)

Figure 10. Diode Forward Voltage vs. Current



10

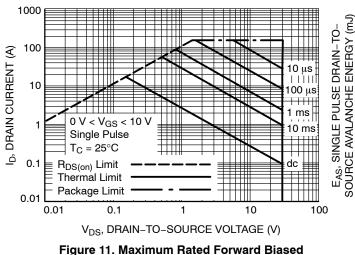
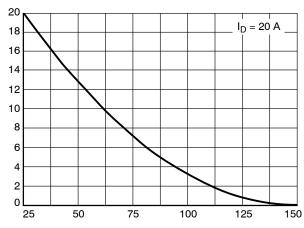


Figure 11. Maximum Rated Forward Biased Safe Operating Area



T_J, STARTING JUNCTION TEMPERATURE (°C)

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

100

TYPICAL CHARACTERISTICS

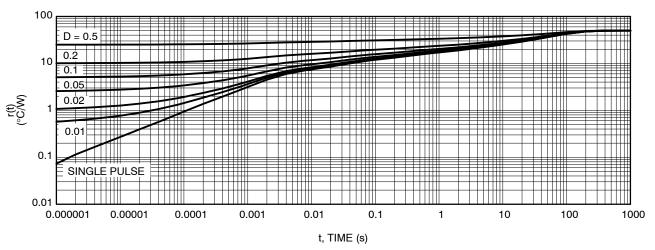


Figure 13. Thermal Response





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N**

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	;		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

SIDE VIEW

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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